

### **Applications**

- IEEE802.11b DSSS WLAN
- IEEE802.11g OFDM WLAN
- IEEE802.11n OFDM WLAN
- General Applications

#### **Features**

- Dual Mode IEEE802.11b & IEEE802.11g
- Integrated PA, digital bias control, 50Ω input and output match, 3.2GHz TX Filter.
- Integrated harmonic filter.
- Integrated load insensitive Power Detector, with <1dB error at 2:1 mismatch</li>
- 20 dBm, 802.11b, 11 Mbps, ACPR <-30 dBc, 3.3V
- 18dBm 802.11g, @ 3.0 % EVM, 54 Mbps, 3.3V
- 20.5dBm, 802.11g @ 3.0 % EVM, 54Mbps, 5.0V
- Lead free, Halogen free, ROHS compliant, 2 x2x0.5 mm QFN package, MSL 1

#### **Product Description**

The SE2568U is a complete 802.11 b/g WLAN discrete power amplifier. The device provides all the functionality of the power amplifier, power detector, filter, associated input, inter-stage and output matching in an ultra compact 2mm x 2mm x 0.5mm form factor.

The SE2568U is designed for ease of use, with all the critical input and output matching integrated. The SE2568U includes a transmitter power detector with 20 dB of dynamic range and a digital Enable for power on/off control. Harmonic filters and an input 3.2GHz LO rejection filter are integrated on-chip. The power ramp rise/fall time is 0.7 µs typical.

#### **Ordering Information**

Part No.	Part No. Package		
SE2568U	8 pin QFN	Samples	
SE2568U-R	8 pin QFN	Tape and Reel	
SE2568U-EK1	N/A	Evaluation kit	

#### **Functional Block Diagram**

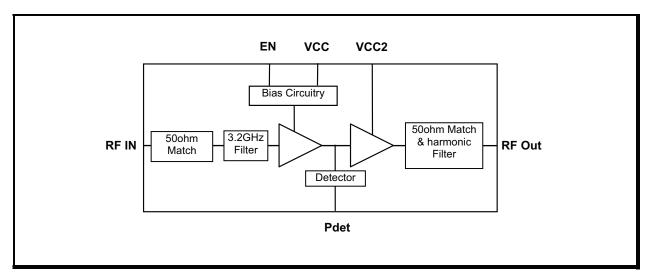


Figure 1: Functional Block Diagram



## **Pin Out Diagram**

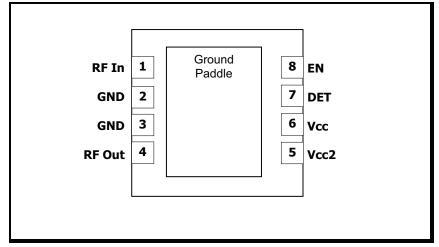


Figure 2: SE2568U Pin Out (Top View Through Package)

## **Pin Out Description**

Pin No.	Name	Description			
1	RF In	RF Input (No DC voltage on the pin, but DC short to ground)			
2	GND	Ground			
3	GND	Ground			
4	RF Out	RF Output (No DC voltage on the pin, DC open to ground)			
5	VCC2	Final Stage Supply Voltage (May attach directly to battery)			
6	VCC	First Stage Supply Voltage (May attach directly to battery)			
7	DET	Power Detector Output			
8	EN	Power Amplifier Enable			
Die paddle	GND	Ground			



### **Absolute Maximum Ratings**

These are stress ratings only. Exposure to stresses beyond these maximum ratings may cause permanent damage to, or affect the reliability of the device. Avoid operating the device outside the recommended operating conditions defined below. This device is ESD sensitive. Handling and assembly of this device should be at ESD protected workstations.

Symbol	Definition	Min.	Max.	Unit
VCC	Supply Voltage on VCC	-0.3	5.5	V
EN	DC input on EN	-0.3	4.0	V
TX	RF Input Power. ANT terminated in $50\Omega$ match	-	12.0	dBm
TA	Operating Temperature Range	-40	85	°C
Тѕтс	Storage Temperature Range	-40	150	°C
ESD <sub>HBM</sub>	JEDEC JESD22-A114	_	500	V
LOD HBM	all pins	-	300	V

### **Recommended Operating Conditions**

Symbol	Parameter	Min.	Тур.	Max.	Unit
TA	Ambient temperature	-40	25	85	°C
	Supply voltage, nominal operation	3.0	3.3	5.0	
VCC	Supply voltage, output power reduced by 2dB typ	2.3	3.0	-	V

### **DC Electrical Characteristics**

Conditions: VCC = 3.3V (default) or VCC = 5.0V (as noted), EN = 3.3V, TA = 25 °C, as measured on SiGe Semiconductor's SE2568U-EK1 evaluation board, all unused ports terminated with 50 ohms, unless otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
lcc-g	Total Supply Current	54 Mbps OFDM signal, 64QAM 18dBm, VCC = 3.3V 20.5dBm, VCC = 5.0V	-	135 150	-	mA
Ісс-н	Total Supply Current	802.11n, MCS7 17dBm, VCC = 3.3V 19dBm, VCC = 5.0V	1	115 130	-	mA
Ісс-в	Total Supply Current	11 Mbps CCK signal, BT = 0.45 20dBm, VCC = 3.3V 22dBm, VCC = 5.0V	-	160 175	-	mA
Icq	Total Supply Current	No RF VCC = 3.3V VCC = 5V	-	90 100	-	mA
Icc_off	Total Supply Current	EN = 0 V, No RF Applied	-	1	10	μΑ



# **Logic Characteristics**

Conditions: VCC = 3.3V (default) or VCC = 5.0V (as noted), EN = 3.3V,  $T_A$  = 25 °C, as measured on SiGe Semiconductor's SE2568U-EK1 evaluation board, all unused ports terminated with 50 ohms, unless

otherwise noted.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
VENH	Logic High Voltage (Module On)		1.8	1	3.6	V
VENL	Logic Low Voltage (Module Off)	-	0	-	0.4	V
lenh	Input Current Logic High Voltage	-	-	2	10	μΑ
lenl	Input Current Logic Low Voltage	-	-	2	10	μА



#### **AC Electrical Characteristics**

### 802.11g/n Transmit Characteristics

Conditions: VCC = 3.3V (default) or VCC = 5.0V (as noted), EN = 3.3V, TA = 25 °C, as measured on SiGe Semiconductor's SE2568U-EK1 evaluation board, all unused ports terminated with 50 ohms, unless otherwise noted.

	otherwise noted.				_		
Symbol	Parameter	Condition		Min.	Тур.	Max.	Unit
Fin	Frequency Range		-	2400	-	2500	MHz
		54Mbps, OFDM,	54Mbps, OFDM, 64 QAM, EVM = 3%		18	-	
	Output Power, 3.3V	11Mbps, CCK, B	T = 0.45, Mask	-	20	-	
	Output Power, 3.3v	802.11n, HT20, a	all data rates, Mask	-	22	-	
Davit		802.11n, HT40, a	all data rates, Mask	-	20	-	alD:sa
Pout		54Mbps, OFDM,	64 QAM, EVM = 3%	-	20.5	-	- dBm
	Outrut Dawar 5 01/	11Mbps, CCK, B	T = 0.45, Mask	-	22	-	1
	Output Power, 5.0V	802.11n, HT20, a	all data rates, Mask	-	24	-	
		802.11n, HT40, a	all data rates, Mask	-	22	-	
P <sub>1dB</sub>	P1dB	-		-	25.0	-	dBm
S <sub>21</sub>	Small Signal Gain	-	-		28	29	dB
Δ\$21	Small Signal Gain	Gain variation over single 20MHz channel		-	0.5	-	dB
	Variation	Gain Variation ov	Gain Variation over band		-	1.1	
S <sub>21</sub> 3.2	Gain @ limit at Ref- vco spur frequency	3206 to 3312 MH	3206 to 3312 MHz		-	15	dB
2f		===	20dBm, 3.3V 22dBm, 5.0V	-	-50	-45	dBm/MHz
3f	Harmonics	1 Mbps, BPSK,	20dBm, 3.3V		-50	-45	dBm/MHz
31			22dBm, 5.0V	-	-48	-43	UDIII/IVITIZ
tdr, tdf	Delay & rise/fall Time	50 % of VEN edge and 90/10 % of final output power level		-	0.7	-	μs
S <sub>11</sub>	Input Return Loss	-		7	10	-	dB
STAB	Stability	CW, Pout = 20 dBm, VCC = 3.3V 0.1 GHz - 20 GHz Load VSWR = 10:1		All non-ha than -42 o	rmonically i dBm/MHz	related out	outs less
RU	Ruggedness	P <sub>IN</sub> = 12dBm, VC Load VSWR = 10		No perma	nent damaç	је	



#### **Power Detector Characteristics**

Conditions: VCC = 3.3V (default) or VCC = 5.0V (as noted), EN = 3.3V, TA = 25 °C, as measured on SiGe Semiconductor's SE2568U-EK1 evaluation board, all unused ports terminated with 50 ohms, unless

otherwise noted.

Symbol	Parameter	Condition	VCC = 3.3V		Condition VCC = 3.3V VCC = 5V			v	Unit
			Min.	Тур.	Max.	Min.	Тур.	Max.	
Fоuт	Frequency Range	-	2400	-	2500	2400	-	2500	MHz
PDR	Power detect range, CW	Measured at ANT	0	-	23	0	-	23	dBm
PDZsrc	DC source impedance on PD_OUT	-	-	1	-	-	1	-	kΩ
PDV <sub>NoRF</sub>	Output Voltage, Pout = No RF	Measured into 1MΩ	-	0.12	-	-	0.12	-	V
PDV <sub>p18</sub>	Output Voltage, Pout = 18 dBm CW	Measured into 1MΩ	-	0.60	-	-	0.55	-	V
PDV <sub>p20</sub>	Output Voltage, Pout = 20 dBm CW	Measured into 1MΩ	-	0.75	-	-	0.70	-	٧
PDV <sub>p23</sub>	Output Voltage, Pout = 23 dBm CW	Measured into 1MΩ	-	NA	-	-	1.00	-	٧
LPF-3dB	Power detect low pass filter -3dB corner frequency	Measured into 1MΩ	260	290	400	270	290	400	kHz

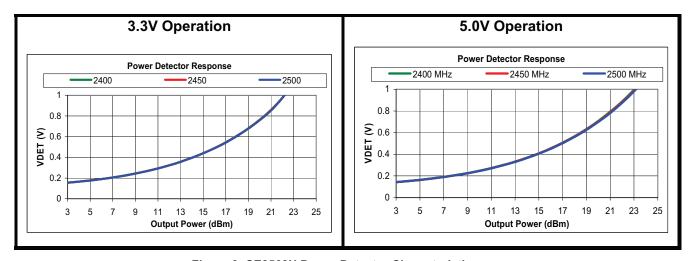


Figure 3: SE2568U Power Detector Characteristics



## **Package Diagram**

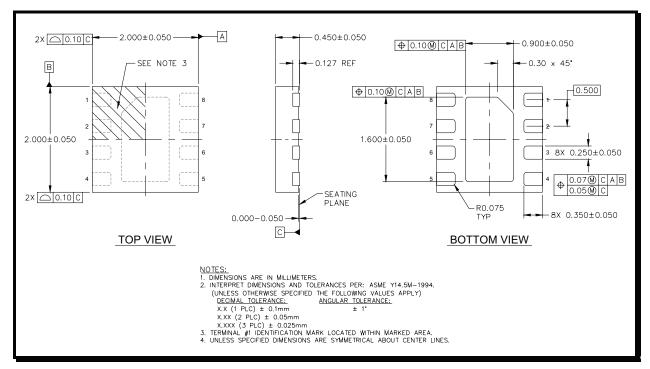


Figure 4: SE2568U Package Diagram

### **Recommended PCB Footprint and Solder pattern**

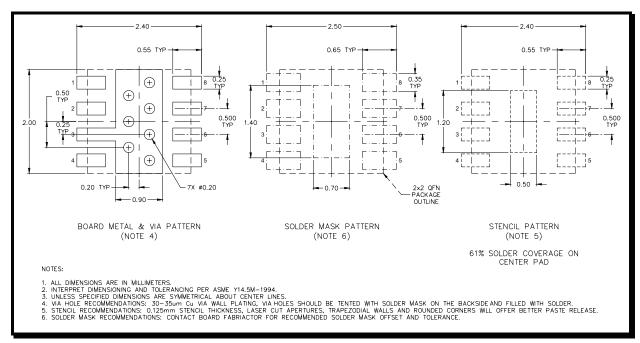


Figure 5: QFN8 2x2mm PCB Footprint



## **Branding Information**

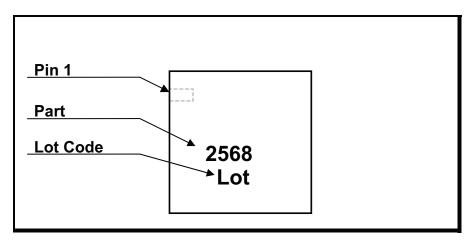


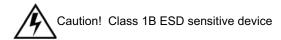
Figure 6: SE2568U Branding and Pin 1 Location (Top View)



#### **Package Handling Information**

Because of its sensitivity to moisture absorption, instructions on the shipping container label must be followed regarding exposure to moisture after the container seal is broken, otherwise, problems related to moisture absorption may occur when the part is subjected to high temperature during solder assembly. The SE2568u is capable of withstanding a Pb free solder reflow. Care must be taken when attaching this product, whether it is done manually or in a production solder reflow environment. If the part is manually attached, precaution should be taken to insure that the device is not subjected to temperatures above its rated peak temperature for an extended period of time. For details on both attachment techniques, precautions, and handling procedures recommended by SiGe, please refer to:

- SiGe's Application Note: "QFN solder reflow and rework information application note", Document Number QAD-00045
- SiGe's Application Note: "Handling, packing, shipping and use of moisture sensitive QFN application note", Document Number QAD-00044



#### **Tape and Reel Information**

Parameter	Value
Devices Per Reel	3000
Reel Diameter	7 inches
Tape Width	12 millimeters

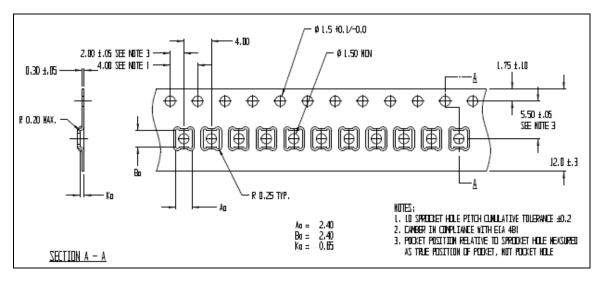


Figure 8: SE2568U-R Tape and Reel Information



# **Document Change History**

Revision	Date	Notes	
1.0	3/17/2008	Created	
1.1	5/01/2008	Updated pin-out	
1.2	7/14/2008	Updated pin-out	
1.3	7/28/2008	Added T&R and pcb footprint recommendation.	
1.4	11/13/2008	Updated CCK performance	
1.5	12/10/08	Updated top marking	
1.6	01/08/2009	Clarified pin designation	
1.7	.2/09/2009	Updated Power detector characteristics	
1.8	03/17/2009	Clarified harmonic measurement condition	
1.9	05/26/2009	Amended back page	
2.0	09/29/2009	Updated leakage current	
2.1	11/12/2009	Corrected Pin 2 definition from "NU" to "GND"	
2.2	1/12/2010	Updated specifications to include 5V operating limits	
2.3	6/10/2010	Updated tape and reel information	
2.4	9/29/2010	Updated minimum recommended operating temperature	
2.5	12/18/2010	Updated ESD rating Added 802.11n Mask Compliant Power Rating	



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#### Product Preview

The datasheet contains information from the product concept specification. SiGe Semiconductor, Inc. reserves the right to change information at any time without notification.

#### Preliminary Information

The datasheet contains information from the design target specification. SiGe Semiconductor, Inc. reserves the right to change information at any time without notification.

Production testing may not include testing of all parameters.

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